

STF16NK60Z STP16NK60Z, STW16NK60Z

N-channel 600 V, 038 Ω, 14 A, TO-220, TO-220FP, TO-247 Zener-protected SuperMESH[™] Power MOSFET

Features

Туре	V _{DSS}	R _{DS(on)} max	I _D	Pw
STF16NK60Z	600 V	< 0.42 Ω	14 A ⁽¹⁾	40 W
STP16NK60Z	600 V	< 0.42 Ω	14 A	190 W
STW16NK60Z	600 V	< 0.42 Ω	14 A	190 W

1. Limited by package.

- 100% avalanche tested
- Extremely high dv/dt capability
- Gate charge minimized
- Very low intrinsic capacitances
- Very good manufacturing repeatability

Application

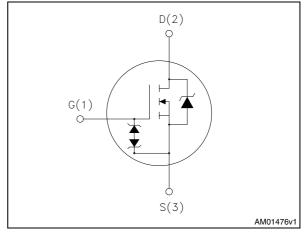
Switching applications

Description

The new SuperMESH[™] series of Power MOSFETS is the result of further design improvements on ST's well-established stripbased PowerMESH[™] layout. In addition to significantly lower on-resistance, the device offers superior dv/dt capability to ensure optimal performance even in the most demanding applications. The SuperMESH[™] devices further complement an already broad range of innovative high voltage MOSFETs, which includes the revolutionary MDmesh[™] products.

TO-220FP	TO-220
	TO-247
	TO-247

Figure 1. Internal schematic diagram



Order codes	Marking	Package	Packaging
STF16NK60Z	F16NK60Z	TO-220FP	
STP16NK60Z	P16NK60Z	TO-220	Tube
STW16NK60Z	W16NK60Z	TO-247	

December 2009

Doc ID 10249 Rev 5

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1 Electrical ratings

Symbol	Parameter	Value	Unit		
Symbol	Falanelei	TO-220 / TO-247	TO-220FP		
V _{DS}	Drain-source voltage ($V_{GS} = 0$)	600	<u>.</u>	V	
V _{GS}	Gate- source voltage	± 30		V	
I _D	Drain current (continuous) at $T_C = 25 \ ^{\circ}C$	14	14 ⁽¹⁾	Α	
Ι _D	Drain current (continuous) at T _C = 100 °C	8.8	8.8 ⁽¹⁾	Α	
I _{DM} ⁽²⁾	Drain current (pulsed)	56	56 ⁽¹⁾	Α	
P _{TOT}	Total dissipation at $T_C = 25 \ ^{\circ}C$	190	40	W	
	Derating factor	1.51		W/°C	
V _{ESD(G-S)}	Gate source ESD(HBM-C = 100 pF, R = 1.5 k Ω)	6000		v	
dv/dt ⁽³⁾	Peak diode recovery voltage slope	4.5		V/ns	
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s; $Tc = 25 °C$)	2500		v	
T _{stg}	Storage temperature	-55 to 150		°C	
Тj	Max. operating junction temperature	150		°C	

Table 2. Absolute maximum ratings

1. Limited by package

2. Pulse width limited by safe operating area

3. I_{SD} $\ \leq \ 14$ A, di/dt $\ \leq \ 200$ A/µs, V_{DD} = 80% V_{(BR)DSS}

Table 3.Thermal data

Symbol	Parameter T		TO-247	TO-220FP	Unit
R _{thj-case}	Thermal resistance junction-case max	0.66		3.1	°C/W
R _{thj-amb}	Thermal resistance junction-ambient max	oient max 62.5 50		62.5	°C/W
TI	Maximum lead temperature for soldering purpose	300		°C	

Table 4. Avalanche characteristics

Symbol Parameter		Max value	Unit
I _{AR}	Avalanche current, repetitive or not-repetitive (pulse width limited by T_j max)	14	А
E _{AS}	Single pulse avalanche energy (starting $T_j = 25 \text{ °C}$, $I_D = I_{AR}$, $V_{DD} = 50 \text{ V}$)	360	mJ



2 Electrical characteristics

(T_C = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_{D} = 1 \text{ mA}, V_{GS} = 0$	620			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = Max rating V _{DS} = Max rating, T _C =125 °C			1 50	μΑ μΑ
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 20 V			± 10	μA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 50 \ \mu A$	3	3.75	4.5	V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10 V, I _D = 7 A		0.38	0.42	Ω

Table 5. On /off states

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} = 25 V, f = 1 MHz, V _{GS} = 0	-	2650 285 62	-	pF pF pF
C _{OSS eq} ⁽¹⁾	Equivalent output capacitance	$V_{GS} = 0, V_{DS} = 0$ to 480 V	-	158	-	pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V _{DD} = 480 V, I _D = 14 A, V _{GS} = 10 V (see <i>Figure 19</i>)	-	86 17 46	-	nC nC nC

1. $C_{oss\;eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_DS increases from 0 to 80% V_{DSS}

Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
t _{d(on)} t _r t _{d(off)} t _f	Turn-on delay time Rise time Turn-off-delay time Fall time	$V_{DD} = 480 \text{ V}, I_D = 14 \text{ A},$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see <i>Figure 18</i>)	-	30 25 70 15	-	ns ns ns ns



Symbol	Parameter	Test conditions	est conditions Min. Typ.		Max.	Unit
I _{SD} I _{SDM} ⁽¹⁾	Source-drain current Source-drain current (pulsed)		-		14 56	A A
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 14 A, V _{GS} = 0	-		1.6	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} = 14 A, di/dt = 100 A/μs V _{DD} = 100 V (see <i>Figure 23</i>)	-	490 5.4 22		ns nC A
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 14 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$ $V_{DD} = 100 \text{ V}, \text{ T}_{j} = 150 ^{\circ}\text{C}$ (see <i>Figure 23</i>)	-	585 7 24		ns nC A

Table 8.Source drain diode

1. Pulse width limited by safe operating area

2. Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%

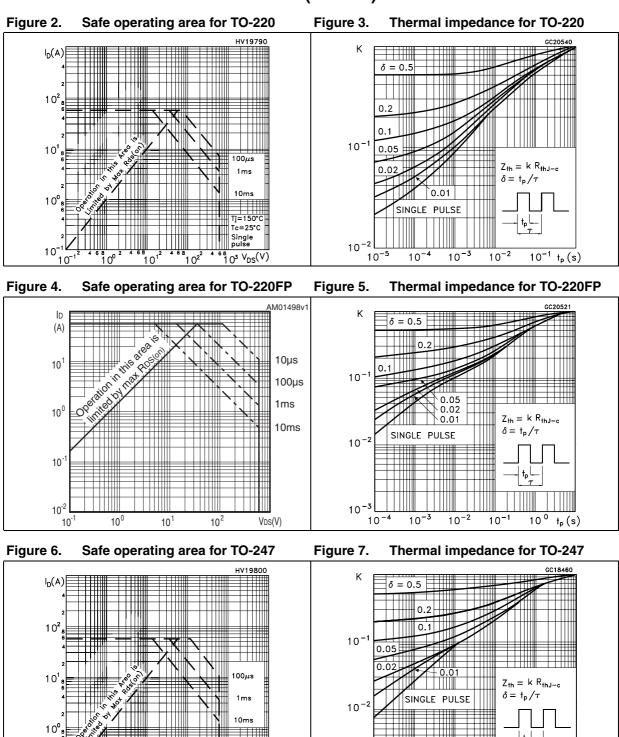
Table 9. Gate-source Ze	ner diode
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Symbol	Parameter	Test conditions	Min	Тур	Max	Unit
BV _{GSO}	Gate-source breakdown voltage	Igs=± 1 mA (open drain)	30	-	-	V

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.



2.1 Electrical characteristics (curves)



10

10

10°

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 10^{-3}

10⁻⁵

 10^{-3}

 10^{-4}

10⁻²

 $10^{-1} t_{p}(s)$

Tj=150°C Tc=25°C Single pulse

103 V_{DS}(V)

4 6

10²²

10¹²

4



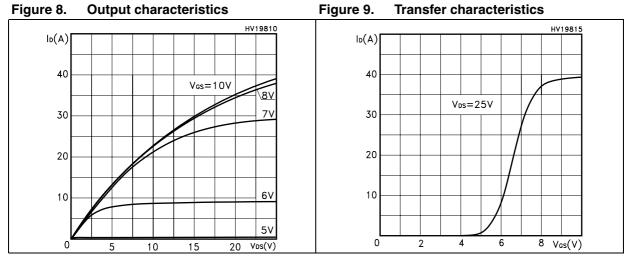


Figure 10. Normalized BV_{DSS} vs temperature Figure 11. Static drain-source on resistance

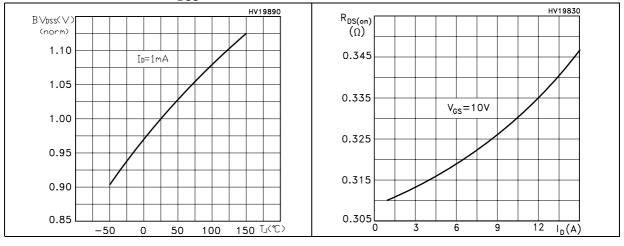
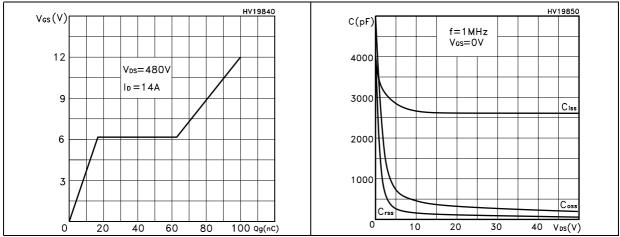


Figure 12. Gate charge vs gate-source voltage Figure 13. Capacitance variations





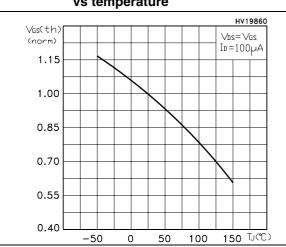
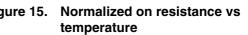


Figure 14. Normalized gate threshold voltage Figure 15. vs temperature



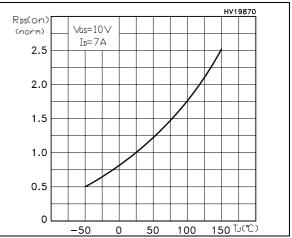
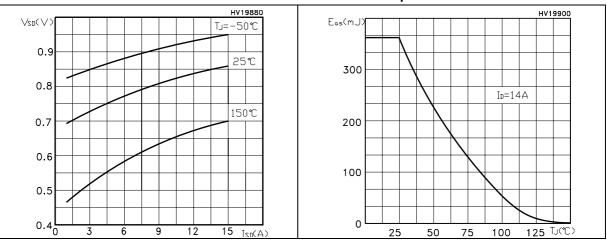


Figure 16. Source-drain diode forward characteristics

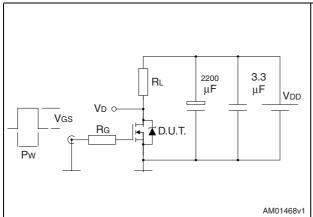
Figure 17. Maximum avalanche energy vs temperature





Test circuits 3

Figure 18. Switching times test circuit for resistive load



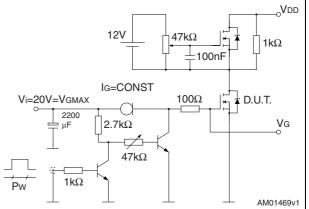
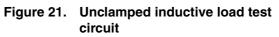
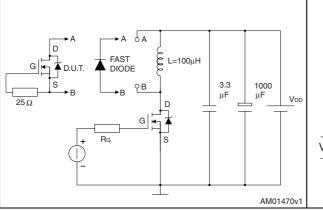
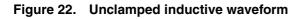


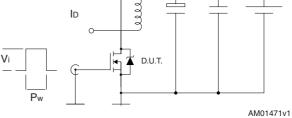
Figure 19. Gate charge test circuit

Figure 20. Test circuit for inductive load switching and diode recovery times









2200

μF

3.3

μF

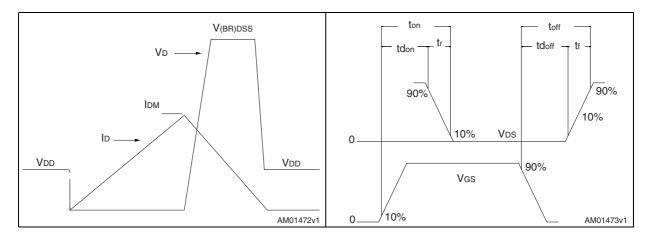
Vdd



VD O

lр

0





4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

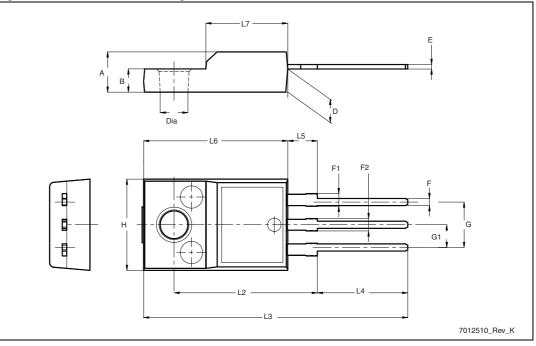
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Dim	mm				
Dim.	Min.	Тур.	Max.		
А	4.4		4.6		
В	2.5		2.7		
D	2.5		2.75		
E	0.45		0.7		
F	0.75		1		
F1	1.15		1.70		
F2	1.15		1.70		
G	4.95		5.2		
G1	2.4		2.7		
Н	10		10.4		
L2		16			
L3	28.6		30.6		
L4	9.8		10.6		
L5	2.9		3.6		
L6	15.9		16.4		
L7	9		9.3		
Dia	3		3.2		

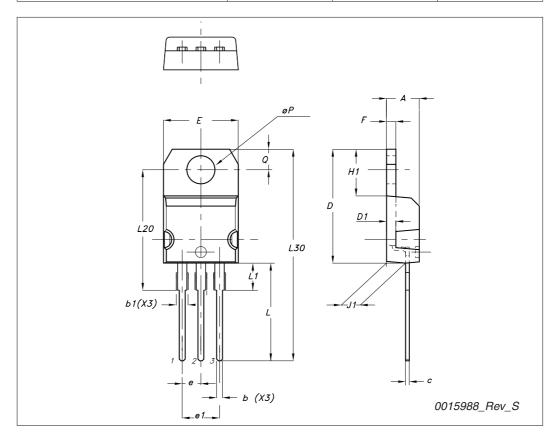
Table 10. TO-220FP mechanical data

Figure 24. TO-220FP drawing





Dim	mm			
Dim	Min	Тур	Мах	
A	4.40		4.60	
b	0.61		0.88	
b1	1.14		1.70	
С	0.48		0.70	
D	15.25		15.75	
D1		1.27		
E	10		10.40	
е	2.40		2.70	
e1	4.95		5.15	
F	1.23		1.32	
H1	6.20		6.60	
J1	2.40		2.72	
L	13		14	
L1	3.50		3.93	
L20		16.40		
L30		28.90		
ØP	3.75		3.85	
Q	2.65		2.95	



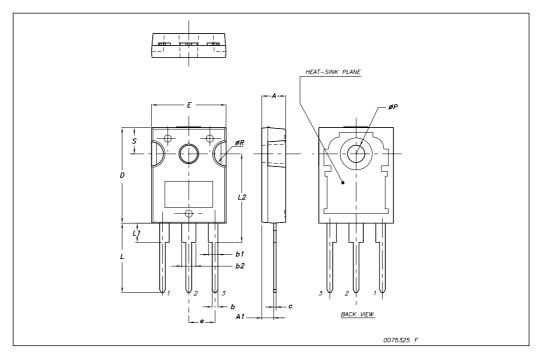


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	TO-247 Mechanical data				
Dim.	mm.				
2	Min.	Тур	Max.		
А	4.85		5.15		
A1	2.20		2.60		
b	1.0		1.40		
b1	2.0		2.40		
b2	3.0		3.40		
С	0.40		0.80		
D	19.85		20.15		
E	15.45		15.75		
е		5.45			
L	14.20		14.80		
L1	3.70		4.30		
L2		18.50			
øP	3.55		3.65		
øR	4.50		5.50		
S		5.50			







5 Revision history

Table 11.Document revision history

Date	Revision	Changes
11-Sep-2006	3	
07-Jun-2007	4	Added statement for ECOPACK [®] .
04-Dec-2009	5	Updated packages mechanical data.

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